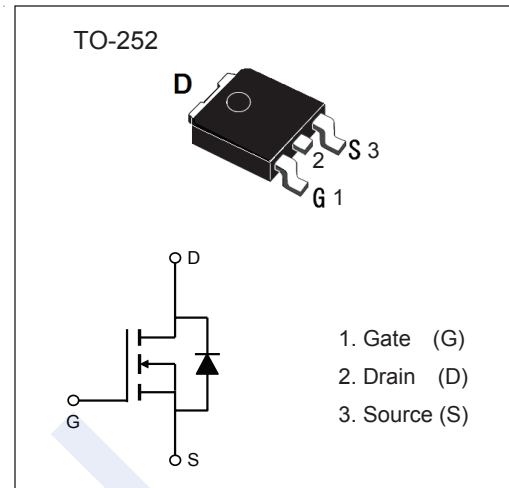


N-Channel MOSFET

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■ Features

- $V_{DS} = 700\text{ V}$
- $I_D = 7\text{ A}$
- $R_{DS(ON)}$ (at $V_{GS} = 10\text{ V}$) $< 0.6\ \Omega$
- $Q_g(\text{typ.}) = 13\text{ nC}$
- 100% avalanche tested

■ Absolute Maximum Ratings ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	700	V
Gate-Source Voltage	V_{GS}	± 30	
Continuous Drain Current	I_D	$T_C = 25^\circ\text{C}$	7
		$T_C = 100^\circ\text{C}$	4.2
Pulsed Drain Current (Note 1)	I_{DM}	21	A
Single Pulse Avalanche Energy (Note 2)	E_{AS}	142	mJ
Repetitive Avalanche Energy (Note 2)	E_{AR}	0.21	
Avalanche Current	I_{AR}	1.3	A
Continuous Body Diode Current	I_S	6	
Pulsed Diode Forward Current (Note 1)	I_{SM}	21	
Thermal Resistance, Junction- to-Ambient	$R_{\theta JA}$	62	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction- to-Case	$R_{\theta JC}$	2.0	
Power Dissipation	P_D	150	W
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-55 to 150	

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. $I_{AS} = 2.4\text{ A}$, $V_{DD} = 50\text{ V}$, $R_G = 25\ \Omega$, Starting $T_J = 25^\circ\text{C}$

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■ Electrical Characteristics (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	I _D = 250 μA, V _{GS} = 0V	700			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 700 V, V _{GS} = 0 V			1	μA
		V _{DS} = 700 V, V _{GS} = 0 V, T _J = 150°C			100	
Gate to Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±30 V			±100	nA
Gate to Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	2.5		4.0	V
Static Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 3.5 A		0.53	0.6	Ω
Gate resistance	R _G	f = 1.0MHz open drain		7		
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 100 V, f = 1 MHz		509		pF
Output Capacitance	C _{oss}			23		
Reverse Transfer Capacitance	C _{rss}			1.5		
Total Gate Charge	Q _g	V _{GS} = 10V, V _{DD} = 520 V, I _D = 7 A		13		nC
Gate Source Charge	Q _{gs}			2.8		
Gate Drain Charge	Q _{gd}			5.6		
Turn-On Delay Time	t _{d(on)}	V _{DD} = 400 V, I _D = 7A, R _{GEN} = 25 Ω		55		ns
Turn-On Rise Time	t _r			61		
Turn-Off Delay Time	t _{d(off)}			117		
Turn-Off Fall Time	t _f			42		
Drain-Source Diode Characteristics						
Body Diode Reverse Recovery Time	t _{rr}	I _F = 7A, di/dt = 100 A/μs, V _R = 400V		321		ns
Body Diode Reverse Recovery Charge	Q _{rr}			3.4		nC
Diode Forward Voltage	V _{SD}	V _{GS} = 0 V, I _S = 3.5 A		0.9	1.2	V

■ Marking

Marking	K5103 KC***
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Figure 1. Output Characteristics

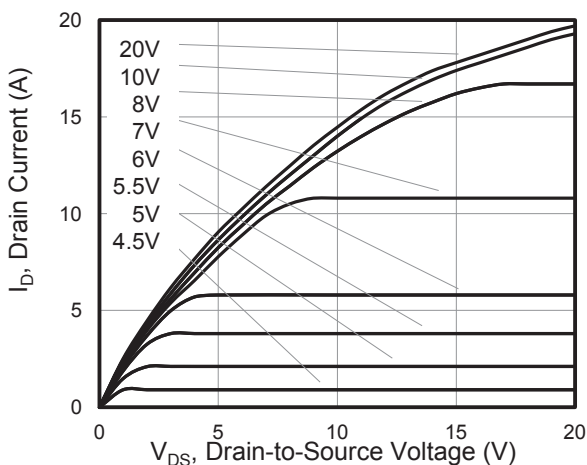


Figure 2. Transfer Characteristics

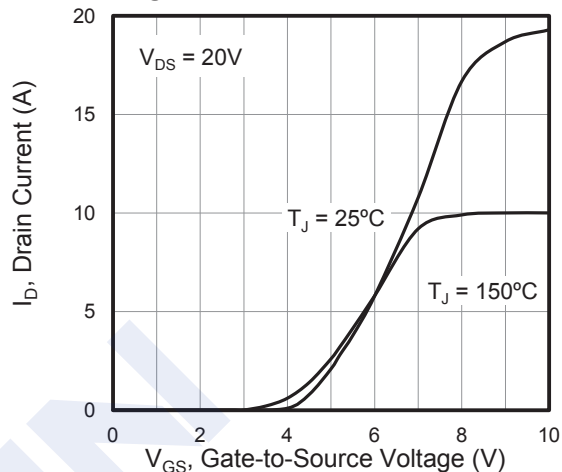


Figure 3. On-Resistance vs. Drain Current

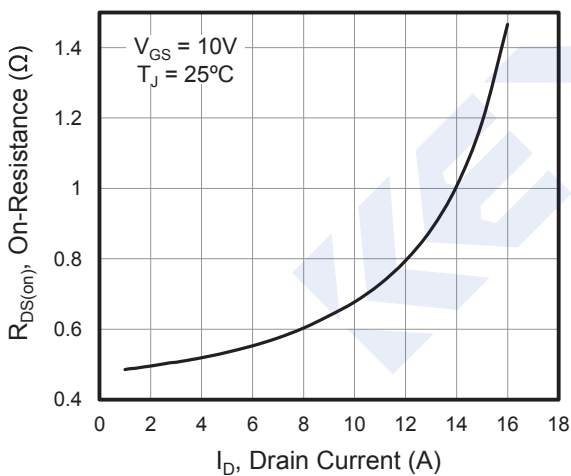


Figure 4. Capacitance

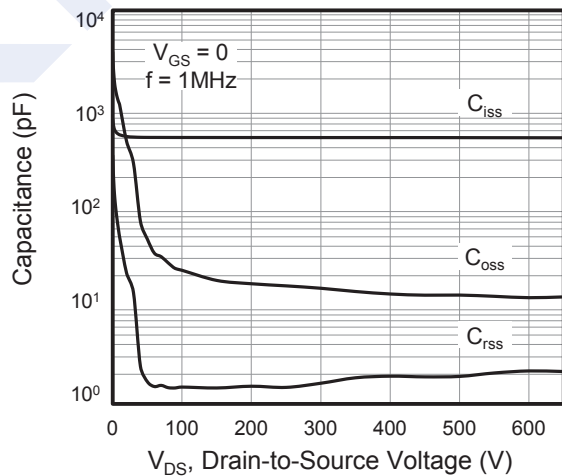


Figure 5. Gate Charge

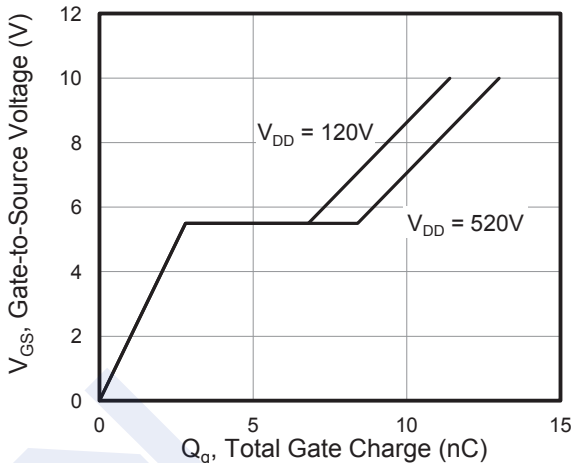
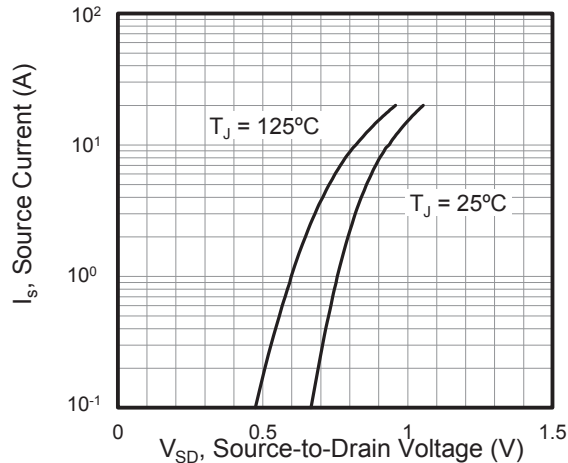


Figure 6. Body Diode Forward Voltage



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Figure 7. On-Resistance vs. Junction Temperature

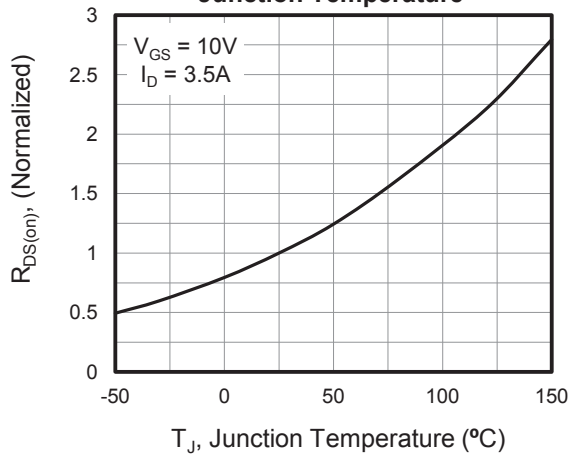


Figure 8. Breakdown voltage vs. Junction Temperature

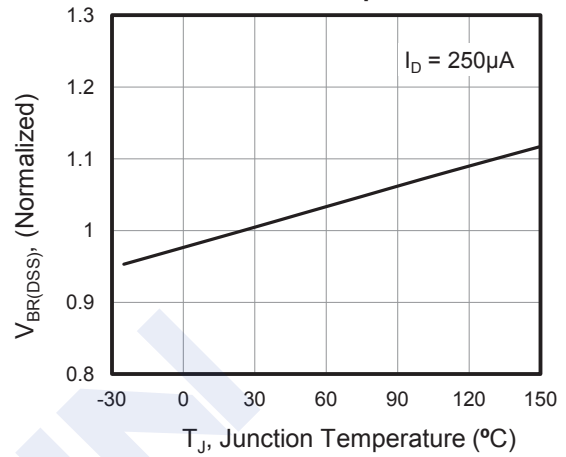


Figure 9. Transient Thermal Impedance TO-252

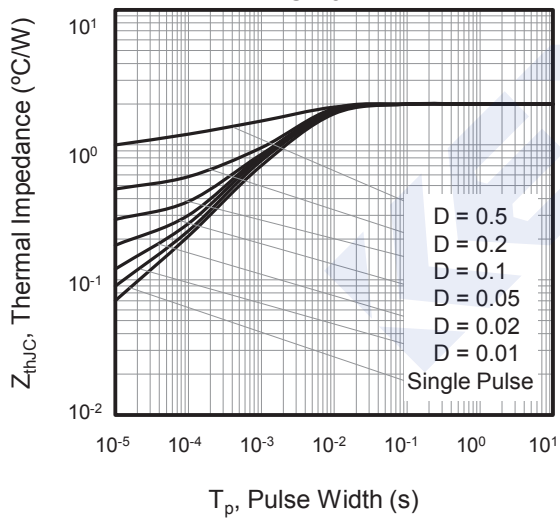
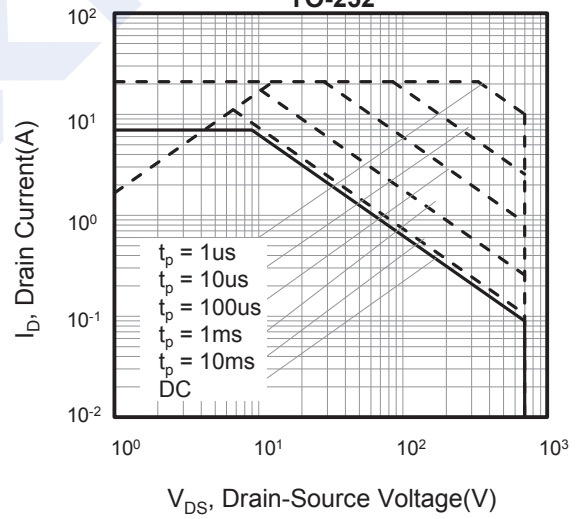


Figure 10. Safe operation area for TO-252



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Figure A: Gate Charge Test Circuit and Waveform

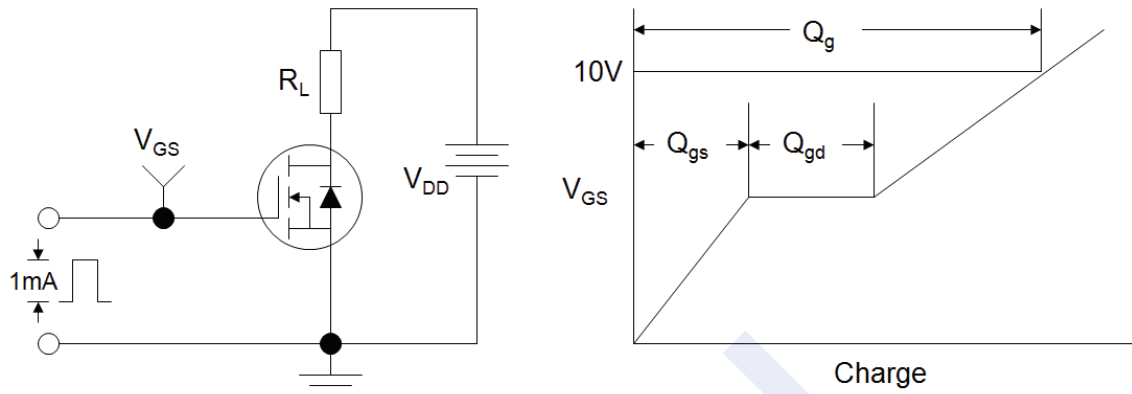


Figure B: Resistive Switching Test Circuit and Waveform

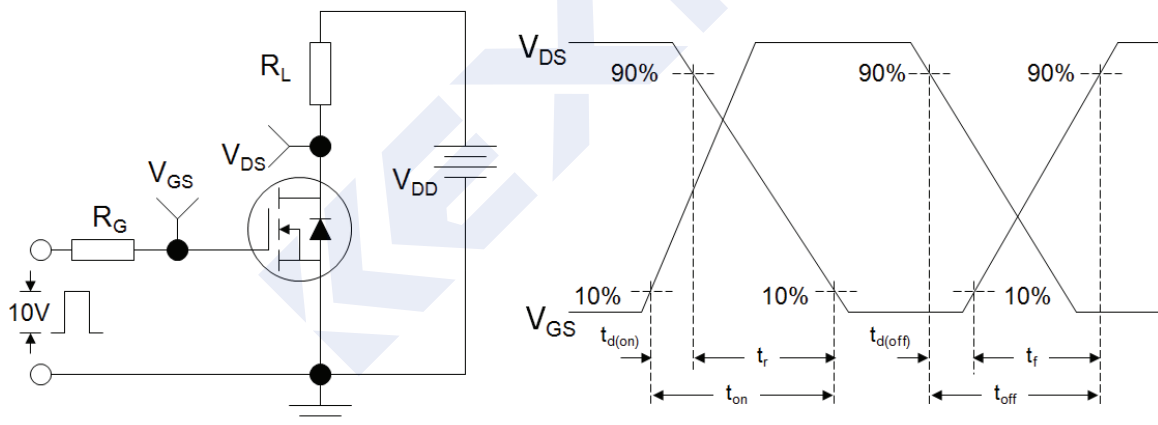
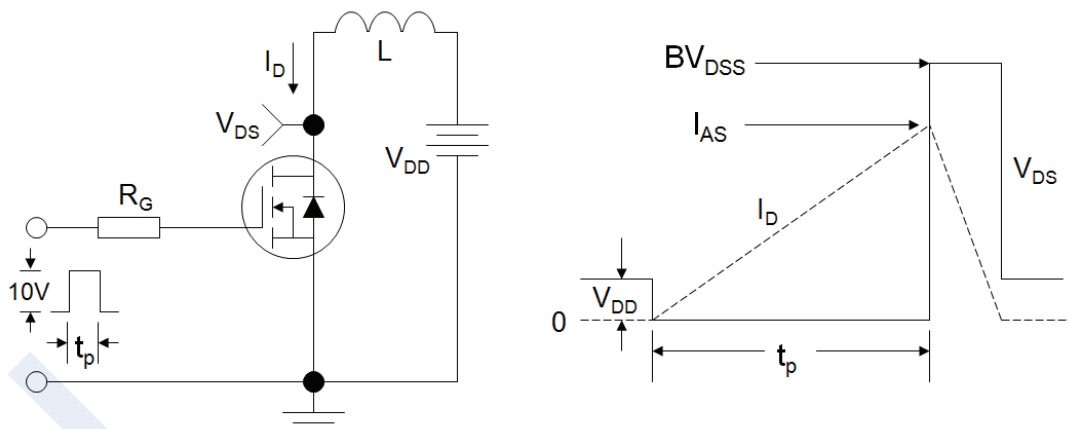


Figure C: Unclamped Inductive Switching Test Circuit and Waveform



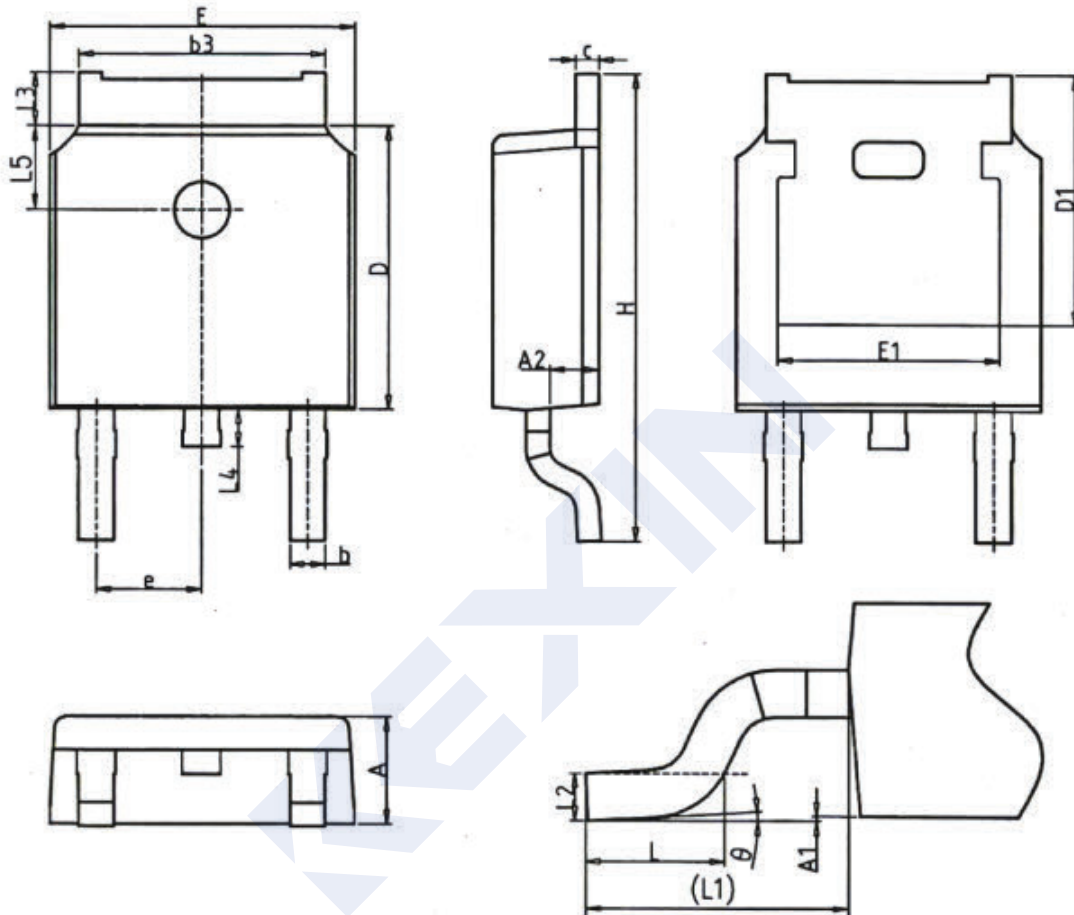
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■ Package Dimension

TO-252

Units: mm



Unit:mm				Unit:mm			
Symbol	Min.	Nom	Max.	Symbol	Min.	Nom	Max.
A	2.20	2.30	2.40	e	2.286 BSC		
A1	0.00	-	0.20	H	9.40	10.10	10.50
A2	0.97	1.07	1.17	L	1.38	1.50	1.75
b	0.68	0.78	0.90	L1	2.90 REF		
b3	5.20	5.33	5.50	L2	0.51 BSC		
c	0.43	0.53	0.63	L3	0.88	-	1.28
D	5.98	6.10	6.22	L4	-	-	1.00
D1	5.30 REF			L5	1.65	1.80	1.95
E	6.40	6.60	6.80	theta	0°	-	8°
E1	4.63	-	-				